## Applicant(s)/Patent Under Application/Control No. Reexamination 10/052,057 JANIK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 **Edan Orgad** 2618 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 03-2004 US-6,711,474 Treyz et al. 701/1 Α US-В US-С US-D US-Ε US-F US-G Н US-US-US-J

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	a					
	R					
	S					
	T	•				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-

US-

US-

Κ

L

М